### **General Description**

The SJD02N2490 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 10V. This device is suitable for use as a wide variety of applications.

#### **Features**

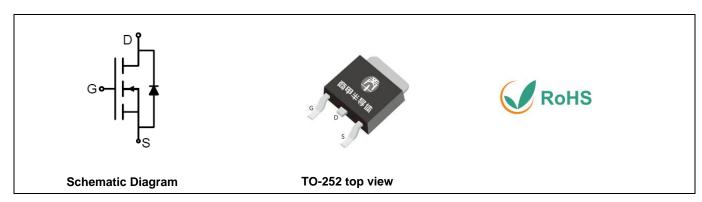
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

#### **Application**

- PWM Applications
- Load Switch
- Power Management

### **Key Performance Parametes**

Parameter	Value	Unit
V <sub>DS</sub>	200	V
R <sub>DS(ON)_TYP</sub>	235	mΩ
I <sub>D</sub>	9	A
Q <sub>G</sub>	29	nC



### **Package Marking and Ordering Information**

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJD02N2490	D02N2490	TO-252	Tape	\	\	2500 Pcs

### Table 1. Absolute Maximum Ratings (T<sub>C</sub>=25℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	200	V
V <sub>GS</sub>	Gate-Source Voltage (V <sub>DS</sub> =0V)	±20	V
I-	Drain Current-Continuous(T <sub>C</sub> =25℃)		А
Drain Current-Continuous(T <sub>C</sub> =100°C)		5.7	А
IDM (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	36	А
Maximum Power Dissipation(T <sub>C</sub> =25 °C)		60	W
P <sub>D</sub> Maximum Power Dissipation(T <sub>C</sub> =100°C)		23.8	W
Eas	Avalanche energy (Note 2)	10	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	°C

#### Table 2. Thermal Characteristic

Symbol	Parameter		Max	Unit
RеJC	Thermal Resistance, Junction-to-Case		2.1	°C/W



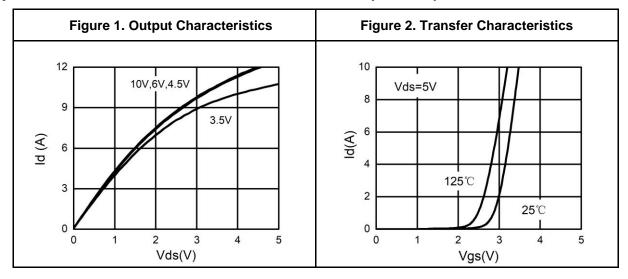
Electrical Characteristics (T<sub>J</sub>=25℃ unless otherwise noted)

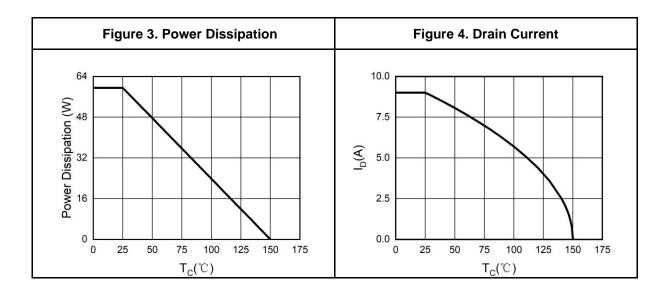
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States	•					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	200			V
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> =200V, V <sub>GS</sub> =0V			1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1		3	V
<b>g</b> FS	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =4A		8		S
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =4A		235	282	mΩ
Dynamic Chara	octeristics		1	•		•
Ciss	Input Capacitance			1442		pF
Coss	Output Capacitance	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, f=1.0MHz		28		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			10.7		pF
Rg	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1.0MHz		0.6		Ω
Switching Para	meters			J		I.
t <sub>d(on)</sub>	Turn-on Delay Time			13		nS
tr	Turn-on Rise Time	Vgs=10V, Vps=100V,		10		nS
$t_{d(off)}$	Turn-Off Delay Time	$R_L=25\Omega$ , $R_{GEN}=5\Omega$		40		nS
t <sub>f</sub>	Turn-Off Fall Time			9		nS
$Q_g$	Total Gate Charge			29		nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =100V, I <sub>D</sub> =4A		4.6		nC
$Q_{gd}$	Gate-Drain Charge			9.8		nC
Source-Drain D	liode Characteristics			ı		l
I <sub>SD</sub>	Source-Drain Current (Body Diode)				9	А
V <sub>SD</sub>	Forward on Voltage (Note 2)	V <sub>GS</sub> =0V, I <sub>S</sub> =4A			1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> =4A, dI/dt=100A/μs		80		ns
Qrr	Reverse Recovery Charge	I <sub>F</sub> =4A, dI/dt=100A/μs		282		nC

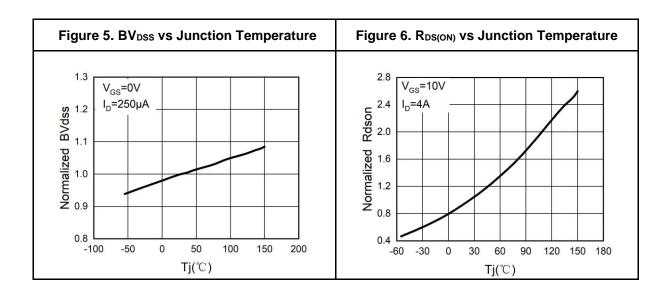
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature. Notes 2.E<sub>AS</sub> condition:  $T_J$ =25°C, $V_{DD}$ =60V, $V_G$ =10V, Rg=25 $\Omega$ , L=0.5mH.

Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.

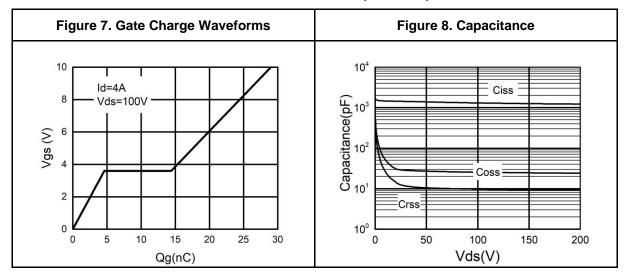
### **Typical Electrical And Thermal Characteristics (Curves)**

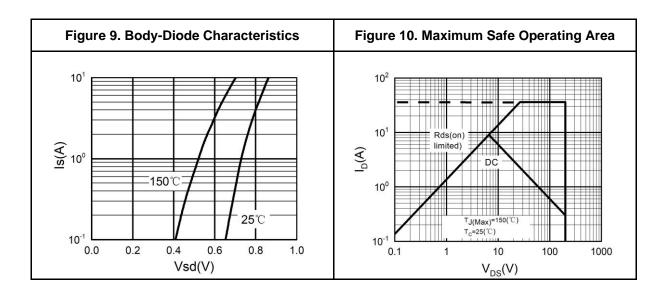


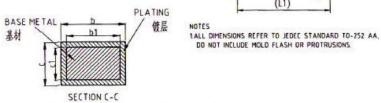




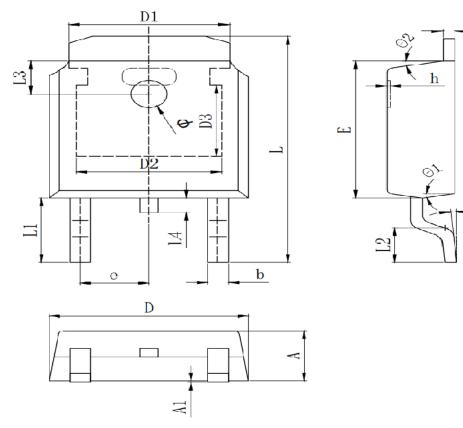
# **Typical Electrical And Thermal Characteristics (Curves)**







K	0. 40REF		
02	5*	7*	9*
0 1	5*	7*	9*
θ	0.	-	8*
L5	1.70	1.80	1.90
14	0.60	0.80	1.00
L3	0.90	-	1. 25
lefe		U, 3103C	



Symbol	Dimensions In Millimeters				
Symbol	Min.	Тур.	Max.		
А	2.200	2.300	2.400		
A1	0.000		0.127		
b	0.640	0.690	0.740		
c(电镀后)	0.460	0.520	0.580		
D	6.500	6.600	6.700		
D1		5.334 REF			
D2		4.826 REF			
D3	3.166 REF				
Е	6.000	6.100	6.200		
е	2.286 TYP				
h	0.000	0.100	0.200		
L	9.900	10.100	10.300		
L1	2.888 REF				
L2	1.400	1.550	1.700		
L3	1.600 REF				
L4	0.600	0.800	1.000		
Ф	1.100	1.200	1.300		
θ	0°		8°		
θ1	9° TYP				
θ2	9° TYP				



### **Attention**

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi shangjia Semiconductor.

The performances and characteristics of this product in the independent testing state are displayed in this document. Wuxi shangjia Semiconductor can't guarantee of the performances and characteristics of this described product that mounted in the customer's products or equipments as same as that in the independent testing state. So the customer should evaluate and test devices mounted in the customer's products or equipments.

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